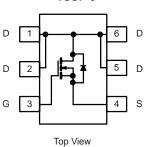


N-Channel 100 V (D-S) MOSFET

PRODUCT SUMMARY							
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^{a, e} Q _g (Typ					
100	0.095 at V _{GS} = 10 V	3.2	4.2 nC				
	0.105 at V _{GS} = 4.5 V	3.0	4.2 110				



TSOP-6



- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET[®] Power MOSFET
- Low On-Resistance
- 100 % R_g Tested
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

• DC/DC Converters, High Speed Switching

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS} 100		V	
Gate-Source Voltage		V _{GS}	± 20	v	
	T _C = 25 °C		3.2 ^e		
Continuous Drain Current (T ₁ = 150 °C)	T _C = 70 °C		2.8 ^e		
Continuous Drain Current $(T_j = 150 \text{ C})$	T _A = 25 °C	I _D	3.0 ^{b, c}		
	T _A = 70 °C		2.4 ^{b, c}	A	
Pulsed Drain Current (t = 300 µs)		I _{DM}	25		
Continuous Source-Drain Diode Current	T _C = 25 °C		2.1		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	1.1 ^{b, c}		
	T _C = 25 °C		2.5		
Maximum Power Dissipation	T _C = 70 °C	P _D	1.6	w	
	T _A = 25 °C		1.3 ^{b, c}	VV	
	T _A = 70 °C	1	0.8 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	<u>.</u>	
Soldering Recommendations (Peak Tempera		260			

THERMAL RESISTANCE RATINGS								
Parameter	Symbol	Typical	Maximum	Unit				
Maximum Junction-to-Ambient ^{b, d}	t ≤ 5 s	R _{thJA}	75	100	°C/W			
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	40	50	0/11			

Notes:

a. Based on $T_C = 25 \ ^{\circ}C$.

b. Surface mounted on 1" x 1" FR4 board.

c. t = 5 s.

d. Maximum under steady state conditions is 166 $^{\circ}\text{C/W}.$

e. Package limited.

SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)								
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit		
Static				1	1	•		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_{D} = 250 \mu A$	100			V		
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μΑ		30		mV/°C		
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}\!/T_J$			- 4.8				
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	1.0		2.5	V		
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA		
Zara Cata Valtaga Drain Current	laaa	$V_{DS} = 100 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1	μA		
Zero Gate Voltage Drain Current	IDSS	V_{DS} = 100 V, V_{GS} = 0 V, T_{J} = 70 °C			10			
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le 5 V, V_{GS} = 10 V$	20			A		
Drain-Source On-State Resistance ^a	P	V _{GS} = 10 V, I _D =3.0 A		0.095		Ω		
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 2 \text{ A}$		0.105				
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 50V$, $I_{D} = 3.0$ A		24		S		
Dynamic ^b					•	•		
Input Capacitance	C _{iss}			424		pF		
Output Capacitance	C _{oss}	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$		100				
Reverse Transfer Capacitance	C _{rss}			42				
Total Gate Charge	Qg	$V_{DS} = 50 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 3.0 \text{ A}$		8.2	13	nC		
				4.2	7			
Gate-Source Charge	Q _{gs}	V _{DS} = 50 V, V _{GS} = 4.5 V, I _D = 3.0 A		1.4				
Gate-Drain Charge	Q _{gd}			1.4				
Gate Resistance	Rg	f = 1 MHz	2.5	12.6	25.2	Ω		
Turn-On Delay Time	t _{d(on)}			6	12	ns		
Rise Time	t _r	V_{DD} = 50 V, R_L = 3.4 Ω		20	30			
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 4.4 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		14	21			
Fall Time	t _f			10	20			
Turn-On Delay Time	t _{d(on)}			3	6			
Rise Time	t _r	V_{DD} = 50 V, R_{L} = 3.4 Ω		11	20			
Turn-Off Delay Time	t _{d(off)}	${\sf I}_{\sf D}\cong$ 2.4 A, ${\sf V}_{\sf GEN}$ = 10 V, ${\sf R}_{\sf g}$ = 1 Ω		20	30			
Fall Time	t _f			7	14			
Drain-Source Body Diode Characteristic	s				1			
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C		2.1				
Pulse Diode Forward Current	I _{SM}			25		A		
Body Diode Voltage	V _{SD}	$I_{S} = 2.4 \text{ A}, V_{GS} = 0 \text{ V}$		0.82	1.2	V		
Body Diode Reverse Recovery Time	t _{rr}			13	20	ns		
Body Diode Reverse Recovery Charge	Q _{rr}			6	12	nC		
Reverse Recovery Fall Time	t _a	$I_F = 2.4 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, \text{ T}_J = 25 ^\circ\text{C}$		8				
Reverse Recovery Rise Time	t _b			5		ns		

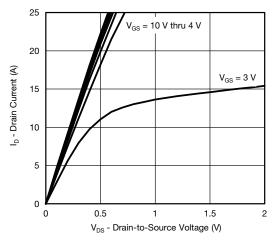
Notes:

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

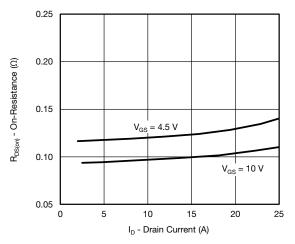
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

semi

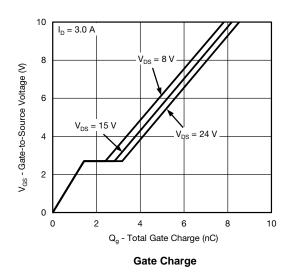


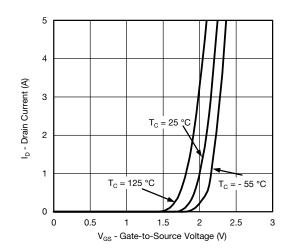




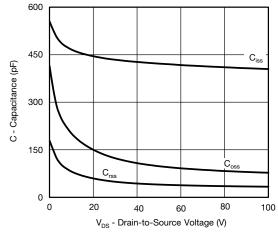


On-Resistance vs. Drain Current and Gate Voltage

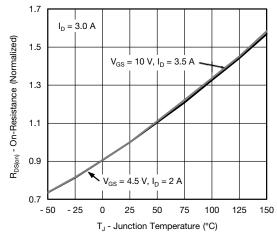




Transfer Characteristics

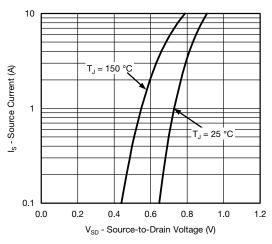


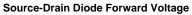


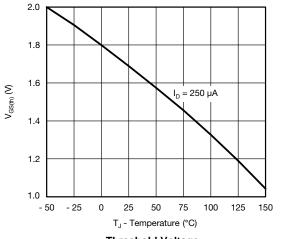


On-Resistance vs. Junction Temperature

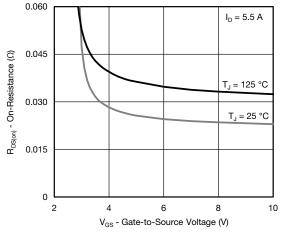




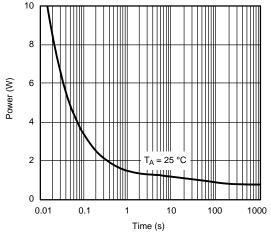




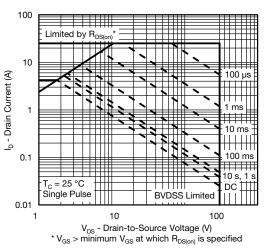




On-Resistance vs. Gate-to-Source Voltage

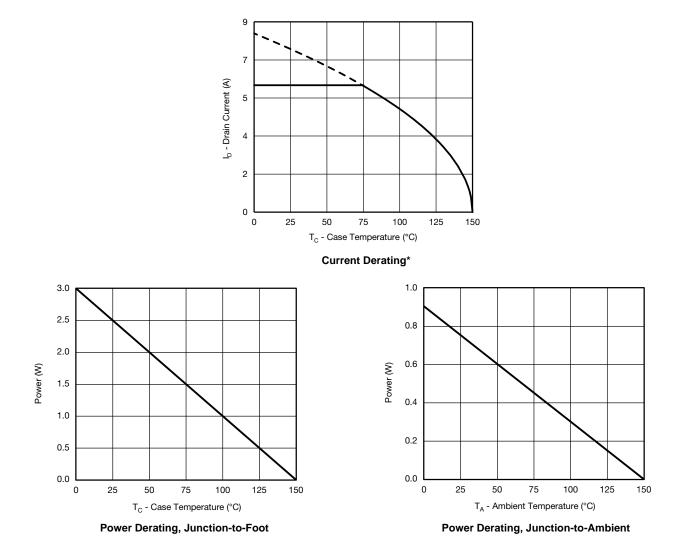


Single Pulse Power (Junction-to-Ambient)



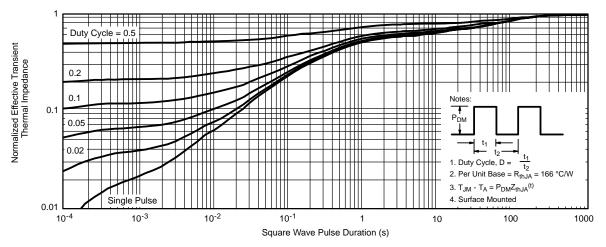
Safe Operating Area, Junction-to-Ambient



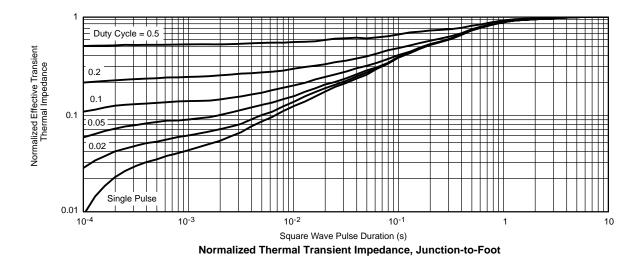


* The power dissipation P_D is based on $T_{J(max.)} = 150 \text{ °C}$, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



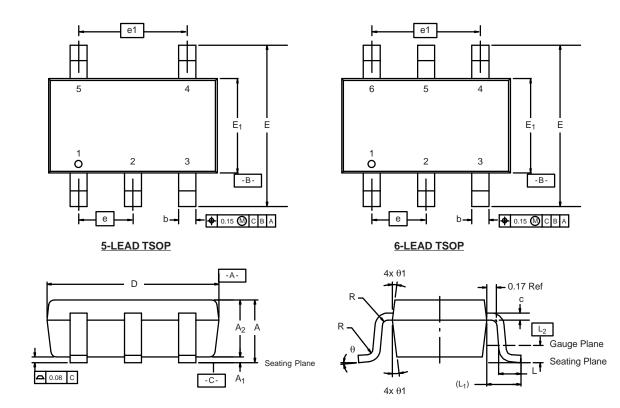


Normalized Thermal Transient Impedance, Junction-to-Ambient





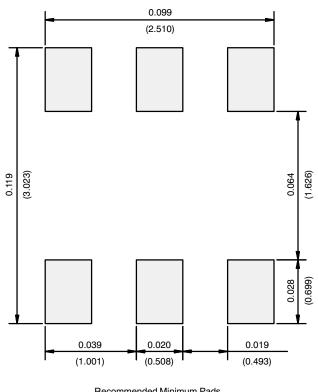
TSOP: 5/6–LEAD JEDEC Part Number: MO-193C



	MILLIMETERS			INCHES			
Dim	Min	Nom	Max	Min	Nom	Max	
Α	0.91	-	1.10	0.036	-	0.043	
A ₁	0.01	-	0.10	0.0004	-	0.004	
A ₂	0.90	-	1.00	0.035	0.038	0.039	
b	0.30	0.32	0.45	0.012	0.013	0.018	
С	0.10	0.15	0.20	0.004	0.006	0.008	
D	2.95	3.05	3.10	0.116	0.120	0.122	
E	2.70	2.85	2.98	0.106	0.112	0.117	
E ₁	1.55	1.65	1.70	0.061	0.065	0.067	
е		0.95 BSC		0.0374 BSC			
e ₁	1.80	1.90	2.00	0.071	0.075	0.079	
L	0.32	-	0.50	0.012	-	0.020	
L ₁	0.60 Ref			0.024 Ref			
L ₂	0.25 BSC			0.010 BSC			
R	0.10	-	-	0.004	-	-	
θ	0°	4°	8°	0°	4°	8°	
θ ₁	7° Nom			7° Nom			
ECN: C-06593-Rev. I, 18-Dec-06 DWG: 5540							



RECOMMENDED MINIMUM PADS FOR TSOP-6



Recommended Minimum Pads Dimensions in Inches/(mm)



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